

<b>Notice of References Cited</b>	Application/Control No. 09/942,504	Applicant(s)/Patent Under Reexamination CHANG ET AL.	
	Examiner Kristie D. Shingles	Art Unit 2141	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,538,992	03-2003	Subbiah et al.	370/230
*	B	US-2005/0286488	12-2005	Briscoe et al.	370/351
*	C	US-7,123,619	10-2006	Lefebvre, Pascal	370/395.1
*	D	US-7,133,400	11-2006	Henderson et al.	370/389
*	E	US-6,788,696	09-2004	Allan et al.	370/411
*	F	US-7,120,150	10-2006	Chase et al.	370/395.1
*	G	US-6,925,057	08-2005	Cheng et al.	370/235
*	H	US-6,556,824	04-2003	Purnadi et al.	455/442
*	I	US-6,999,432	02-2006	Zhang et al.	370/328
*	J	US-6,862,622	03-2005	Jorgensen, Jacob W.	709/226
*	K	US-5,995,490	11-1999	Shaffer et al.	370/260
*	L	US-7,093,028	08-2006	Shao et al.	709/240
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.